



AO3705

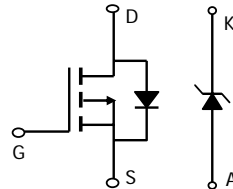
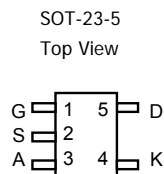
P-Channel Enhancement Mode Field Effect Transistor with Schottky Diode

General Description

The AO3705/L uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge. A Schottky diode is provided to facilitate the implementation of a bidirectional blocking switch, or for buck convertor applications.
 AO3705 and AO3705L are electrically identical.
 -RoHs Complaint
 -AO3705L is Halogen Free

Features

V_{DS} (V) = -20V
 I_D = -3.2A (V_{GS} = -4.5V)
 $R_{DS(ON)} < 70m\Omega$ (V_{GS} = -4.5V)
 $R_{DS(ON)} < 90m\Omega$ (V_{GS} = -2.5V)
 $R_{DS(ON)} < 110m\Omega$ (V_{GS} = -1.8V)
 $R_{DS(ON)} < 130m\Omega$ (V_{GS} = -1.5V)
SCHOTTKY
 V_{DS} (V) = 20V, I_F = 1A, $V_F < 0.45V@1A$



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | MOSFET | Schottky | Units |
|-----------------------------------------|----------------|------------------------|----------|------------------|
| Drain-Source Voltage | V_{DS} | -20 | | V |
| Gate-Source Voltage | V_{GS} | ± 8 | | V |
| Continuous Drain Current ^A | I_D | $T_A=25^\circ\text{C}$ | -3.2 | A |
| | | $T_A=70^\circ\text{C}$ | -2.5 | |
| Pulsed Drain Current ^B | I_{DM} | -25 | | |
| Schottky reverse voltage | V_{KA} | | 20 | V |
| Continuous Forward Current ^A | I_F | $T_A=25^\circ\text{C}$ | 1 | A |
| | | $T_A=70^\circ\text{C}$ | 0.5 | |
| Pulsed Forward Current ^B | I_{FM} | | 10 | |
| Power Dissipation | P_D | $T_A=25^\circ\text{C}$ | 1.15 | W |
| | | $T_A=70^\circ\text{C}$ | 0.7 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | | $^\circ\text{C}$ |

| Parameter: Thermal Characteristics MOSFET | | Symbol | Typ | Max | Units |
|-------------------------------------------|--------------|-----------------|------|-----|--------------------|
| Maximum Junction-to-Ambient ^A | $t \leq 10s$ | $R_{\theta JA}$ | 80.3 | 110 | $^\circ\text{C/W}$ |
| | Steady-State | | 117 | 150 | |
| Maximum Junction-to-Lead ^C | Steady-State | $R_{\theta JL}$ | 43 | 80 | |
| Thermal Characteristics Schottky | | | | | |
| Maximum Junction-to-Ambient ^A | $t \leq 10s$ | $R_{\theta JA}$ | 153 | 190 | $^\circ\text{C/W}$ |
| | Steady-State | | 173 | 220 | |
| Maximum Junction-to-Lead ^C | Steady-State | $R_{\theta JL}$ | 103 | 140 | |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|--------------------------------------------------------------------------------------------|------|----------|-----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =-250μA, V _{GS} =0V | -20 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =-20V, V _{GS} =0V T _J =55°C | | | -1 -5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±8V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =-250μA | -0.5 | -0.65 | -1 | V |
| I _{D(ON)} | On state drain current | V _{GS} =-4.5V, V _{DS} =-5V | -25 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =-4.5V, I _D =-3.2A T _J =125°C | | 56 80 | 70 100 | mΩ |
| | | V _{GS} =-2.5V, I _D =-2.8A | | 70 | 90 | mΩ |
| | | V _{GS} =-1.8V, I _D =-2A | | 85 | 110 | mΩ |
| | | V _{GS} =-1.5V, I _D =-0.5A | | 100 | 130 | mΩ |
| g _{FS} | Forward Transconductance | V _{DS} =-5V, I _D =-3.2A | | 15 | | S |
| V _{SD} | Diode Forward Voltage | I _S =-1A, V _{GS} =0V | | -0.7 | -1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | -1.2 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =-10V, f=1MHz | | 560 | 745 | pF |
| C _{oss} | Output Capacitance | | 80 | | | pF |
| C _{rss} | Reverse Transfer Capacitance | | 70 | | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 15 | 23 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g | Total Gate Charge | V _{GS} =-4.5V, V _{DS} =-10V, I _D =-3.2A | | 8.5 | 11 | nC |
| Q _{gs} | Gate Source Charge | | 1.2 | | | nC |
| Q _{gd} | Gate Drain Charge | | 2.1 | | | nC |
| t _{D(on)} | Turn-On Delay Time | V _{GS} =-4.5V, V _{DS} =-10V, R _L =3Ω, R _{GEN} =6Ω | | 7.2 | | ns |
| t _r | Turn-On Rise Time | | 36 | | | ns |
| t _{D(off)} | Turn-Off Delay Time | | 53 | | | ns |
| t _f | Turn-Off Fall Time | | 56 | | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =-3.2A, dI/dt=100A/μs | | 37 | 49 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =-3.2A, dI/dt=100A/μs | | 27 | | nC |
| SCHOTTKY PARAMETERS | | | | | | |
| V _F | Forward Voltage Drop | I _F =1A | | 0.4 | 0.45 | V |
| I _{rm} | Maximum reverse leakage current | V _R =16V | | | 0.1 | mA |
| | | V _R =16V, T _J =125°C | | | 20 | |
| C _T | Junction Capacitance | V _R =10V | | 44 | | pF |
| t _{rr} | Schottky Reverse Recovery Time | I _F =1A, dI/dt=100A/μs | | 11 | 14 | ns |
| Q _{rr} | Schottky Reverse Recovery Charge | I _F =1A, dI/dt=100A/μs | | 2.5 | | nC |

A: The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

Rev1: May 2008

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

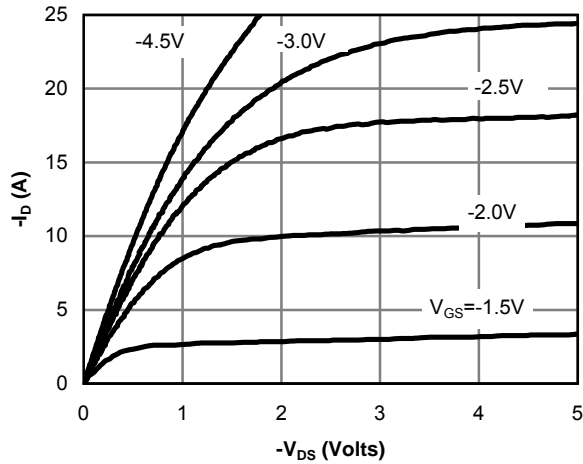


Figure 1: On-Region Characteristics

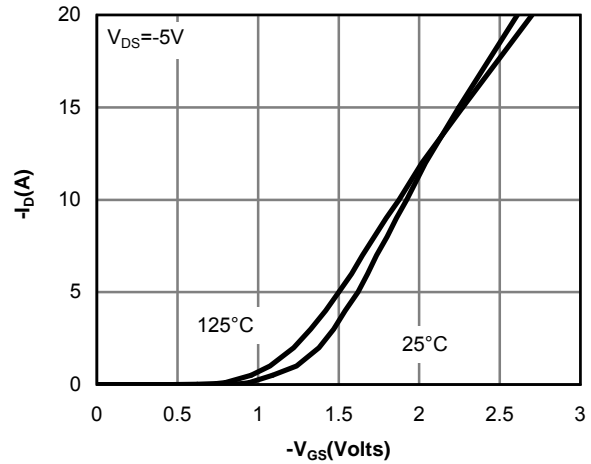


Figure 2: Transfer Characteristics

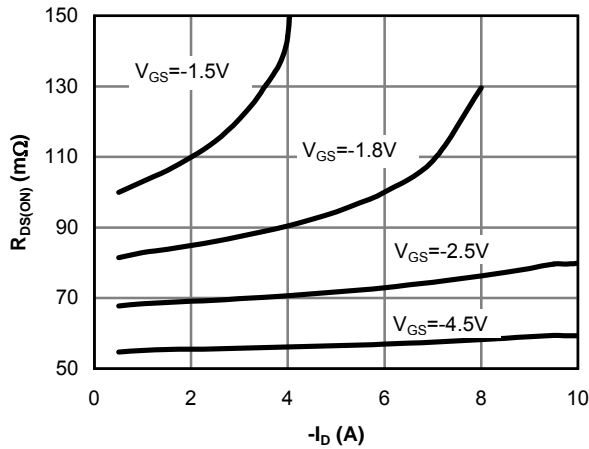


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

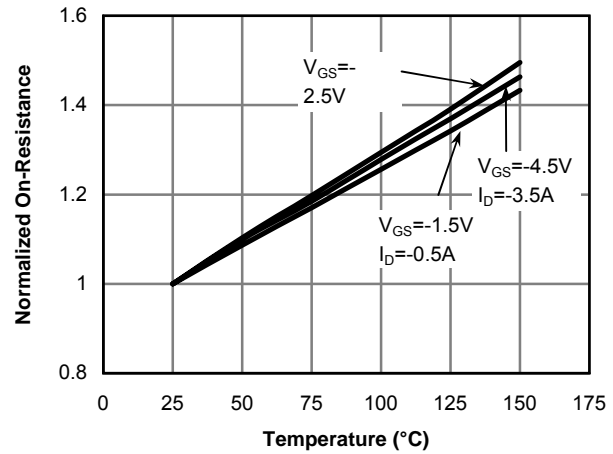


Figure 4: On-Resistance vs. Junction Temperature

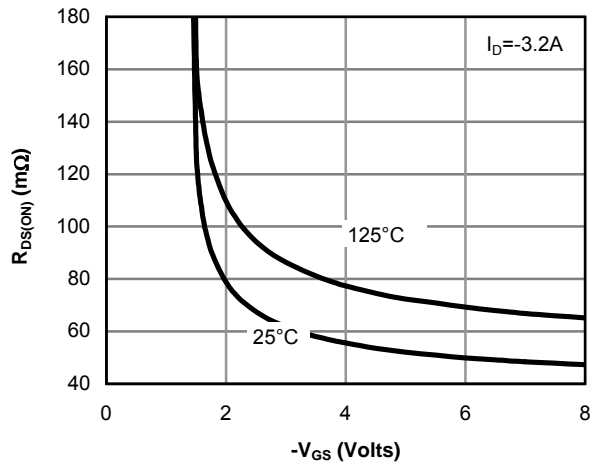


Figure 5: On-Resistance vs. Gate-Source Voltage

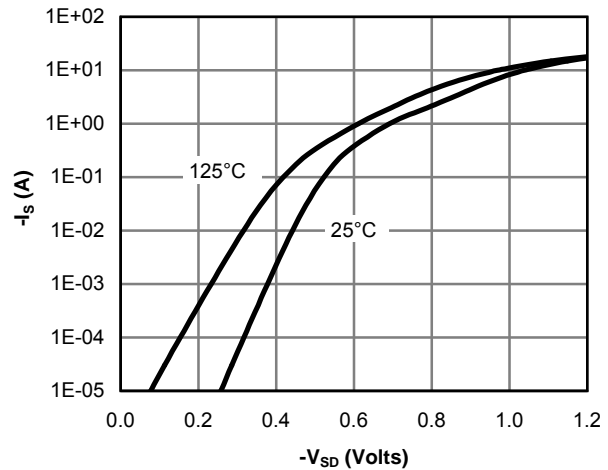


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

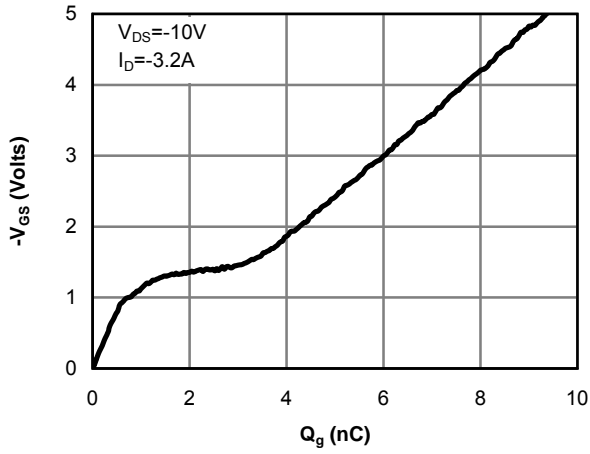


Figure 7: Gate-Charge Characteristics

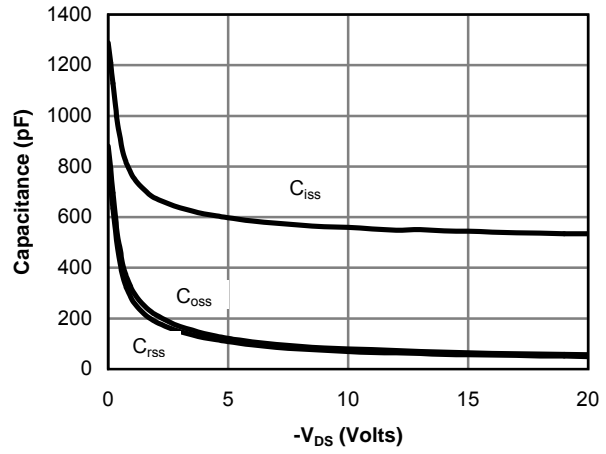


Figure 8: Capacitance Characteristics

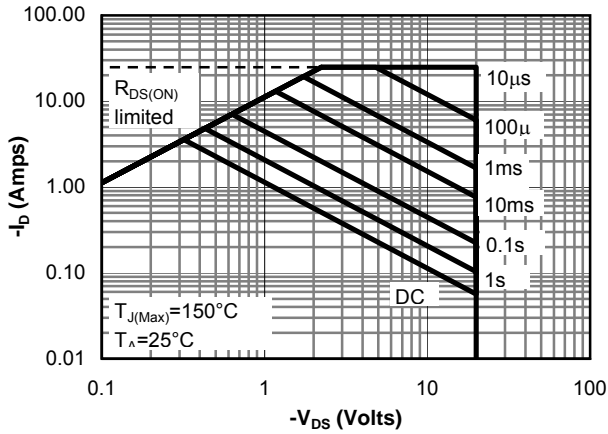


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

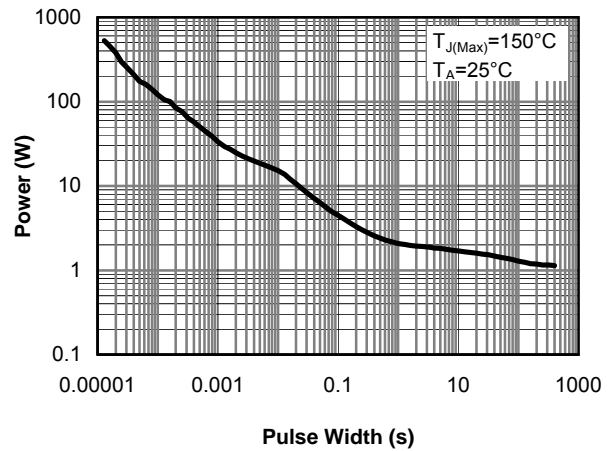


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

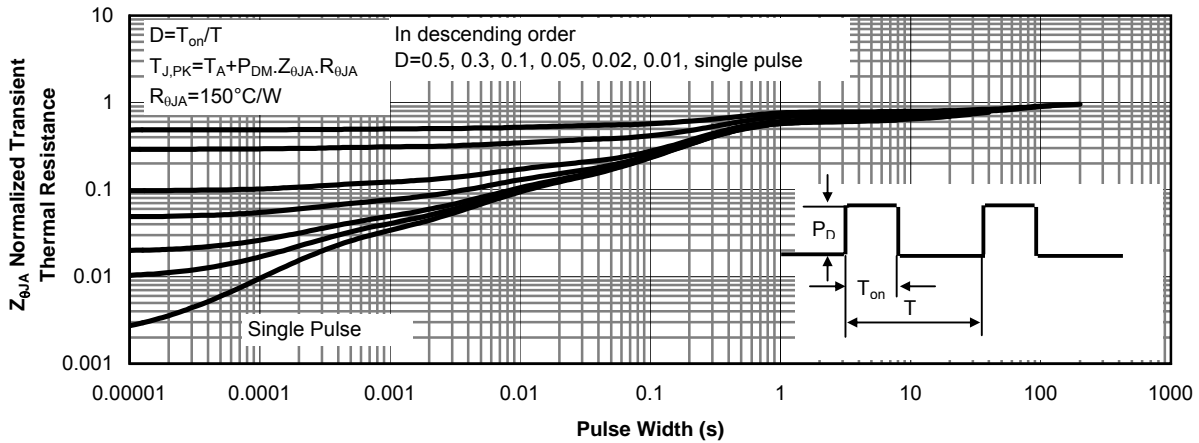


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: SCHOTTKY

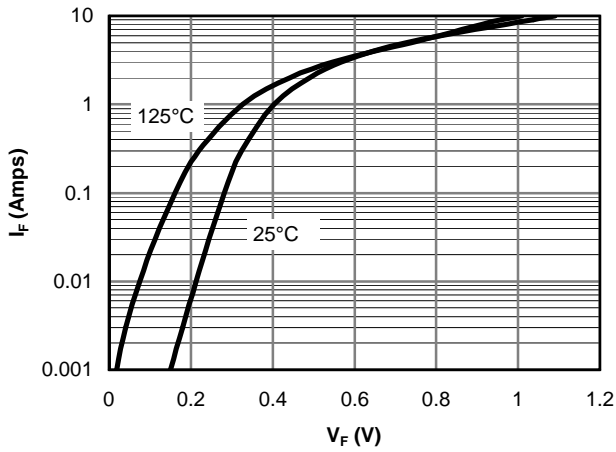


Figure 12: Schottky Forward Characteristics

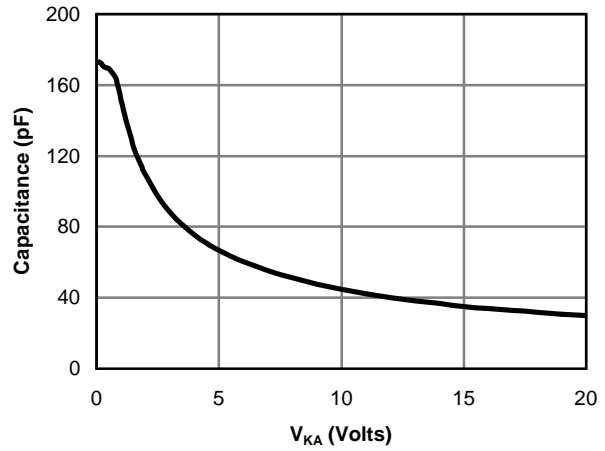


Figure 13: Schottky Capacitance Characteristics

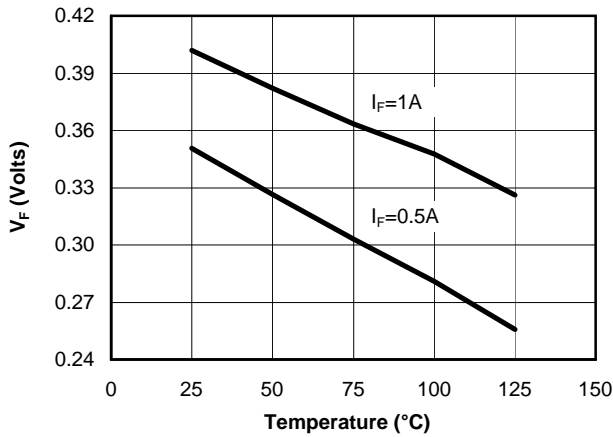


Figure 14: Schottky Forward Drop vs. Junction Temperature

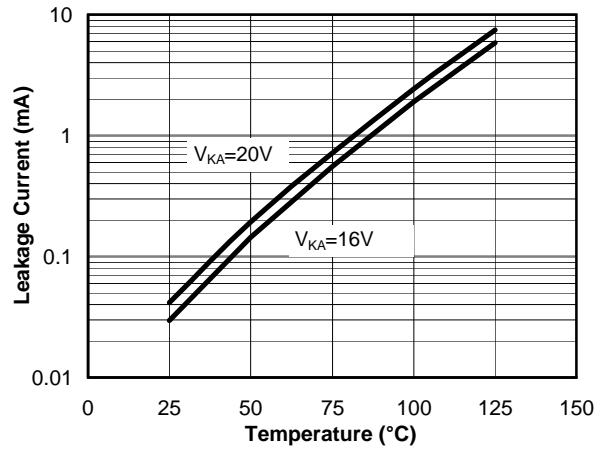


Figure 15: Schottky Leakage Current vs. Junction Temperature

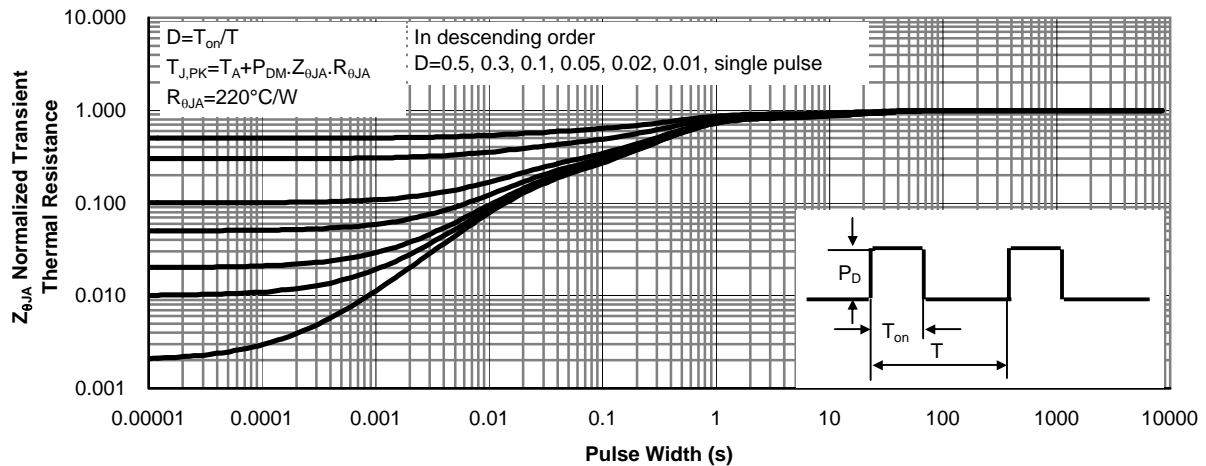


Figure 16: Schottky Normalized Maximum Transient Thermal Impedance